

<b>Notice of References Cited</b>	Application/Control No. 10/697,988		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Sonny TRINH		Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,313,688	11-2001	Lee et al.	327/359
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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